

April 2013

# FDPF320N06L

# N-Channel PowerTrench<sup>®</sup> MOSFET 60 V, 21 A, 25 m $\Omega$

#### **Features**

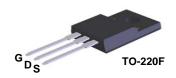
- $R_{DS(on)} = 20 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 10 \text{ V, } I_D = 21 \text{ A}$
- $R_{DS(on)} = 23 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 5 \text{ V, } I_D = 17 \text{ A}$
- Low Gate Charge (Typ. 23.2 nC)
- Low C<sub>rss</sub> (Typ. 64 pF)
- · Fast Switching
- 100% Avalanche Tested
- · Improved dv/dt Capability
- RoHS Compliant

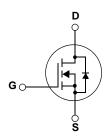
# **Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor<sup>®</sup>'s PowerTrench<sup>®</sup> process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

# **Applications**

- · Consumer Appliances
- LCD / LED / PDP TV





# MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted\*

Symbol		Parameter		FDPF320N06L	Unit
V <sub>DSS</sub>	Drain to Source Voltage			60	V
V <sub>GSS</sub>	Gate to Source Voltage			±20	V
1	Drain Current	- Continuous (T <sub>C</sub> = 25°C)		21	А
ID	Drain Current	- Continuous (T <sub>C</sub> = 100°C)		15	A
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	84	Α
E <sub>AS</sub>	Single Pulsed Avalanche Ene	rgy	(Note 2)	66	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	6.0	V/ns
D	Davier Dissipation	$(T_C = 25^{\circ}C)$		26	W
P <sub>D</sub> Power Dissipation		- Derate above 25°C		0.17	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Tempo	erature Range		-55 to +175	οС
T <sub>L</sub>	Maximum Lead Temperature 1/8" from Case for 5 Seconds	• •		300	°C

<sup>\*</sup>Drain current limited by maximum junction temperature

### **Thermal Characteristics**

Symbol	Parameter FDPF320N06L		Unit	
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max. 5.8			
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. 62.5		°C/W	

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDPF320N06L	FDPF320N06L	TO-220F	=	-	50

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$ , Referenced to $25^{\circ}\text{C}$	-	0.04	-	V/°C
ı	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 48V, V <sub>GS</sub> = 0V	-	-	1	μА
I <sub>DSS</sub>	Zero Gate voltage Drain Current	$V_{DS} = 48V, T_C = 150^{\circ}C$	-	-	500	μΑ
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	μА

# On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	-	2.5	V
D	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 21A$	-	20	25	mΩ
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 5V, I_{D} = 17A$	-	23	38	mΩ
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10V, I_{D} = 21A$	-	34	-	S

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance			-	1105	1470	pF
C <sub>oss</sub>	Output Capacitance		$V_{DS} = 25V, V_{GS} = 0V$ $f = 1MHz$		115	150	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 = 11VII 12			64	-	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V	V <sub>GS</sub> = 10V		-	23.2	30.2	nC
Q <sub>g(tot)</sub>	Total Gate Charge at 5V	$V_{GS} = 5V$	.,	-	12.7	16.5	nC
$Q_{gs}$	Gate to Source Gate Charge		<sup></sup> V <sub>DS</sub> = 48V I <sub>D</sub> = 21A	-	3.4	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge		$I_D = 2IA$ (Note 4)	-	6.3	-	nC

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	16	42	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 30V, I_{D} = 21A$		34	78	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 5V$ , $R_{GEN} = 4.7\Omega$	-	27	64	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)	-	8	26	ns
ESR	Equivalent Series Resistance (G-S)	f = 1MHz	-	2	-	Ω

### **Drain-Source Diode Characteristics**

IS	Maximum Continuous Drain to Source Diode Forward Current			-	21	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	84	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 21A$	-	-	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0V, I_{SD} = 21A, V_{DD} = 48V$	-	27	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge dI <sub>F</sub> /dt = 100A/μs		-	23	-	nC

- **Notes:**1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 1mH,  $I_{AS}$  = 11.5A,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25°C
- 3.  $I_{SD} \le 21 \text{A}$ , di/dt  $\le 200 \text{A}/\mu \text{s}$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ} C$
- 4. Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

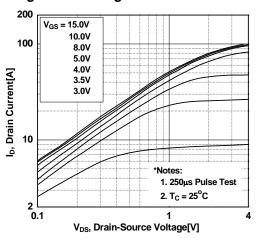
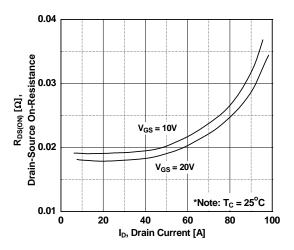


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage



**Figure 5. Capacitance Characteristics** 

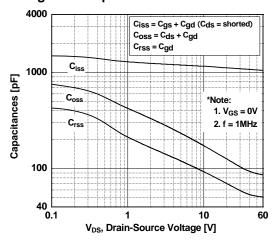


Figure 2. Transfer Characteristics

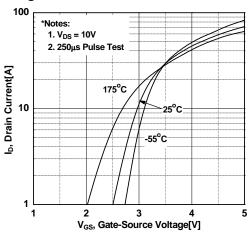


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

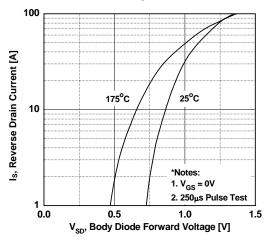
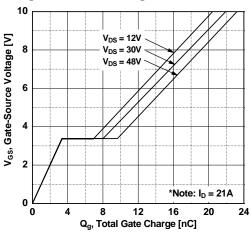


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

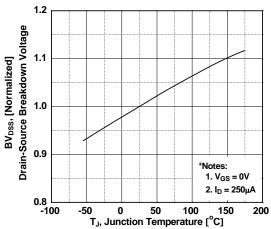


Figure 9. Maximum Safe Operating Area

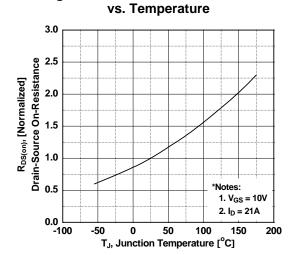
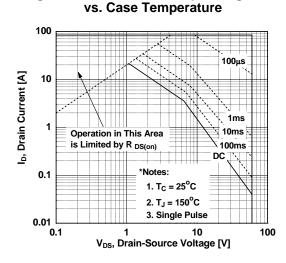


Figure 8. On-Resistance Variation

Figure 10. Maximum Drain Current



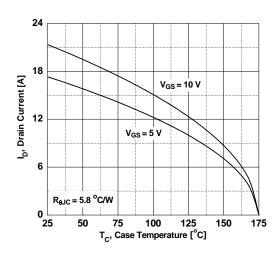
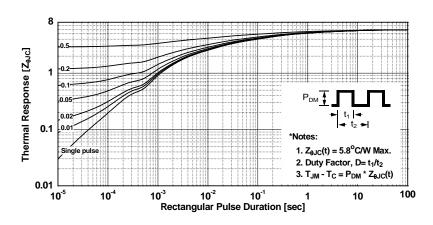
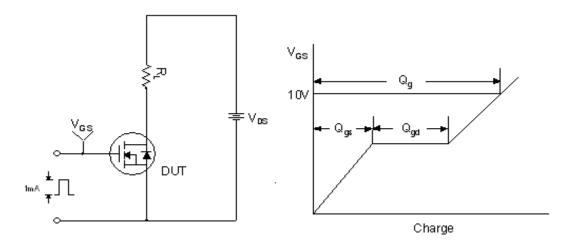


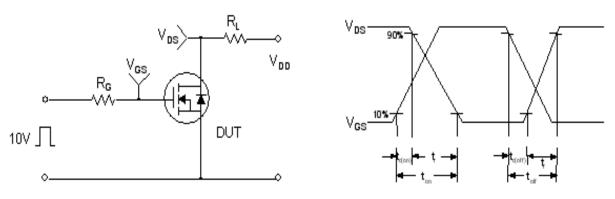
Figure 11. Transient Thermal Response Curve



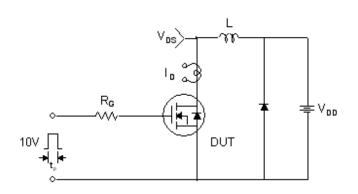
# **Gate Charge Test Circuit & Waveform**

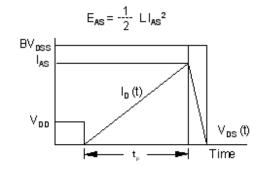


# **Resistive Switching Test Circuit & Waveforms**

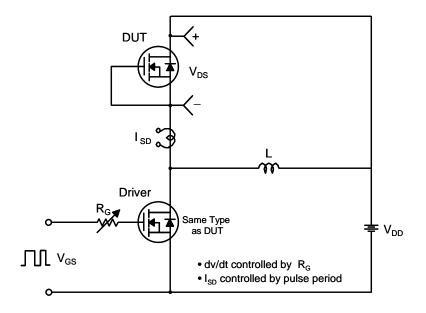


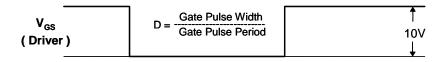
**Unclamped Inductive Switching Test Circuit & Waveforms** 

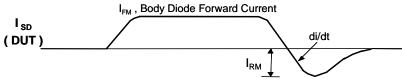




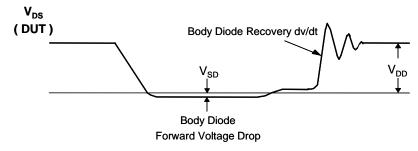
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms





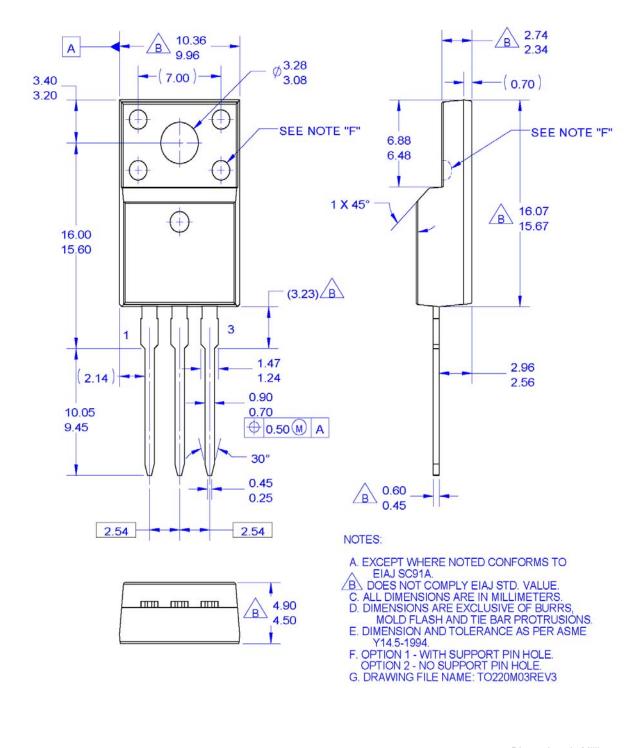


Body Diode Reverse Current



# **Mechanical Dimensions**

# TO-220M03







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